## FDMC6675BZ

## P-Channel POWERTRENCH ${ }^{\circledR}$ MOSFET

-30 V, -20 A, $14.4 \mathrm{~m} \Omega$

## Description

The FDMC6675BZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest $\mathrm{R}_{\mathrm{DS}(\text { on })}$ and ESD protection.

## Features

- $\operatorname{Max} \mathrm{R}_{\mathrm{DS}(\text { on })}=14.4 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$
- $\operatorname{Max} \mathrm{R}_{\mathrm{DS}(\text { on })}=27.0 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-6.9 \mathrm{~A}$
- HBM ESD Protection Level of 8 kV Typical (Note 3)
- Extended $\mathrm{V}_{\text {GSS }}$ Range $(-25 \mathrm{~V})$ for Battery Applications
- High Performance Trench Technology for Extremely Low $\mathrm{R}_{\mathrm{DS}(o n)}$
- High Power and Current Handling Capability
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free/BFR Free and are RoHS Compliant


## Typical Applications

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management

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| $\mathbf{V}_{\mathbf{D S}}$ | $\mathbf{R}_{\mathbf{D S} \text { (on) }}$ MAX | $\mathbf{I}_{\mathbf{D} \text { MAX }}$ |
| :---: | :---: | :---: |
| -30 V | $14.4 \mathrm{~m} \Omega @ 10 \mathrm{~V}$ | -20 A |



MARKING DIAGRAM
\$Y\&Z\&2\&K
FDMC
6675BZ

| $\$ Y$ | $=$ ON Semiconductor Logo |
| :--- | :--- |
| $\& Z$ | $=$ Assembly Plant Code |
| $\& 2$ | $=$ Numeric Date Code |
| $\& K$ | $=$ Lot Code |
| FDMC6675BZ | $=$ Specific Device Code |

ORDERING INFORMATION
See detailed ordering and shipping information on page 2 of this data sheet.

MOSFET MAXIMUM RATINGS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$, Unless otherwise specified)

| Symbol | Parameter | Ratings | Unit |
| :---: | :---: | :---: | :---: |
| $V_{\text {DS }}$ | Drain to Source Voltage | -30 | V |
| $\mathrm{V}_{\mathrm{GS}}$ | Gate to Source Voltage | $\pm 25$ | V |
| $\mathrm{I}_{\mathrm{D}}$ | Drain Current - Continuous $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | -20 | A |
|  | - Continuous $\quad \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (Note 1a) | -9.5 |  |
|  | - Pulsed | -32 |  |
| $P_{D}$ | Power Dissipation $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 36 | W |
|  | Power Dissipation $\quad \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ (Note 1a) | 2.3 |  |
| $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Ratings | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JJC}}$ | Thermal Resistance, Junction to Case | 3.4 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {ӨJA }}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 |  |

PACKAGE MARKING AND ORDERING INFORMATION

| Device Marking | Device | Package | Reel Size | Tape Width | Shipping (Qty / Packing) ${ }^{\dagger}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FDMC6675BZ | FDMC6675BZ | WDFN8 3.3x3.3, 0.65P <br> (MLP) <br> (Pb-Free/Halogen Free) | $13^{\prime \prime}$ | 12 mm | $3000 /$ Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |

OFF CHARACTERISTICS

| $\mathrm{BV}_{\text {DSS }}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | -30 | - | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{BV}_{\mathrm{DSS}}}{\Delta \mathrm{~T}_{\mathrm{J}}}$ | Breakdown Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | - | -20 | - | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| ${ }_{\text {l }}^{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=-24 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DS}}=-24 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{aligned}$ | - | - | $\begin{gathered} \hline-1 \\ -100 \end{gathered}$ | $\mu \mathrm{A}$ |
| IGSS | Gate to Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 25 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | - | - | $\pm 10$ | $\mu \mathrm{A}$ |

## ON CHARACTERISTICS

| $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | Gate to Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | -1.0 | -1.9 | -3.0 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{V}_{\mathrm{GS}(\mathrm{th})}}{\Delta \mathrm{T}_{\mathrm{J}}}$ | Gate to Source Threshold Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ | - | -6.0 | - | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | Static Drain to Source On Resistance | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 10.7 | 14.4 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-6.9 \mathrm{~A}$ | - | 17.4 | 27.0 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}, \mathrm{~T}_{J}=125^{\circ} \mathrm{C}$ | - | 15.2 | 20.5 |  |
| gFS | Forward Transconductance | $\mathrm{V}_{\mathrm{DD}}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 28 | - | S |

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{j}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)
DYNAMIC CHARACTERISTICS

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\mathrm{V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{~V}$ GS $=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | - | 2154 | 2865 | pF |  |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  | - | 392 | 525 | pF |  |
|  | $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  | - | 349 | 525 | pF |

SWITCHING CHARACTERISTICS

| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-On Delay Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=-10 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{GEN}}=6 \Omega \end{aligned}$ | - | 11 | 20 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | - | 10 | 20 |  |
| $t_{\text {d(off) }}$ | Turn-off Delay Time |  | - | 44 | 71 |  |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | - | 26 | 42 |  |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to -10 V, $\mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 46 | 65 | nC |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to $-5 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 26 | 37 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Charge | $\mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 6.4 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge | $\mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9.5 \mathrm{~A}$ | - | 13 | - | nC |

DRAIN-SOURCE DIODE CHARACTERISTICS

| $\mathrm{V}_{\text {SD }}$ | Source to Drain Diode Forward Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-9.5 \mathrm{~A}($ Note 2) | - | -0.89 | -1.3 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=-1.6 \mathrm{~A}($ Note 2) | - | -0.73 | -1.2 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{I}_{\mathrm{F}}=-9.5 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{S}$ | - | 24 | 38 | ns |
| $Q_{\text {rr }}$ | Reverse Recovery Charge |  | - | 15 | 27 | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta J A}$ is determined with the device mounted on a $1 \mathrm{in}^{2}$ pad 2 oz copper pad on a $1.5 \times 1.5 \mathrm{in}$. board of $F R-4$ material. $R_{\theta C A}$ is determined by the user's board design.

a) $53^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a $1 \mathrm{in}^{2}$ pad of 2 oz copper

b) $125^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a minimum pad
2. Pulse Test: Pulse Width < $300 \mu \mathrm{~s}$, Duty cycle $<2.0 \%$.
3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS
( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 1. On-Region Characteristics


Figure 3. Normalized On Resistance vs Junction Temperature


Figure 5. Transfer Characteristics


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage


Figure 4. On-Resistance vs Gate to Source Voltage


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

( $T_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 7. Gate Charge Characteristics


Figure 9. Unclamped Inductive Switching Capability

$\mathrm{V}_{\mathrm{DS}}$, Drain to Source Voltage (V)

Figure 11. Forward Bias Safe Operating Area


Figure 8. Capacitance vs Drain to Source Voltage


Figure 10. Maximum Continuous Drain Current vs Case Temperature


Figure 12. $\mathrm{I}_{\mathrm{gss}}$ vs $\mathrm{V}_{\text {gss }}$

## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

( $T_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 13. Single Pulse Maximum Power Dissipation


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

WDFN8 3.3x3.3, 0.65P
CASE 511DQ
ISSUE O
DATE 31 OCT 2016


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